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The CID number appears on each page of the manuscript. The complete citation is used on the first page, and an abbreviated version on subsequent pages. Numbers in the index correspond to the last two digits of the six-digit CID number.

Contents

ix *Conference Committee*

SESSION 1 PRELAUNCH CALIBRATION

- 7452 03 **Spectral features: how to reduce them** [7452-02]
H. van Brug, D. ten Bloemendal, B. de Goeij, TNO Science and Industry (Netherlands);
R. Vink, L. Maresi, ESA ESTEC (Netherlands)
- 7452 04 **The extension of the NIST BRDF scale from 1100 nm to 2500 nm** [7452-03]
H. W. Yoon, D. W. Allen, G. P. Eppeldauer, B. K. Tsai, National Institute of Standards and
Technology (United States)
- 7452 05 **Progress in BRDF calibration measurements in the SWIR** [7452-04]
G. T. Georgiev, Sigma Space (United States); J. J. Butler, NASA Goddard Space Flight Ctr.
(United States)
- 7452 06 **Development of a filter radiometer monitor system for integrating sphere sources** [7452-05]
L. Ding, M. G. Kowalewski, J. W. Cooper, G. R. Smith, Science Systems and Applications, Inc.
(United States); J. J. Butler, NASA Goddard Space Flight Ctr. (United States)

SESSION 2 NPOESS PREPARATORY PROJECT

- 7452 07 **Radiometric calibration of the OMPS instruments for NPOESS** [7452-06]
S. C. Bennett, Ball Aerospace & Technologies Corp. (United States)
- 7452 08 **Radiometric calibration of 100-cm sphere integrating source for Visible/Infrared
Imager/Radiometer Suite (VIIRS)** [7452-07]
E. D. Kim, R. Menzel, J. R. Moore, Raytheon Space & Airborne Systems (United States)
- 7452 09 **VIIRS polarization testing** [7452-08]
E. Waluschka, NASA Goddard Space Flight Ctr. (United States)
- 7452 0A **A VIIRS ocean data simulator** [7452-09]
W. D. Robinson, F. S. Patt, Science Applications International Corp. (United States);
B. A. Franz, NASA Goddard Space Flight Ctr. (United States); K. R. Turpie, Science
Applications International Corp. (United States); C. R. McClain, NASA Goddard Space Flight
Ctr. (United States)

SESSION 3 NEW MISSIONS

- 7452 0C **Desert test site uniformity analysis** [7452-11]
D. X. Kerola, Skillstorm Government Integrated Services (United States); C. J. Bruegge, Jet
Propulsion Lab. (United States)

- 7452 OD **SENTINEL-2 image quality and level 1 processing** [7452-12]
A. Meygret, Ctr. National d'Études Spatiales (France) and ESA ESTEC (Netherlands); S. Baillarin, Ctr. National d'Études Spatiales (France) and ESA ESRIN (Italy); F. Gascon, ESA ESTEC (Netherlands); E. Hillairet, Magellium (France); C. Dechoz, S. Lacherade, Ctr. National d'Études Spatiales (France); P. Martimort, F. Spoto, ESA ESTEC (Netherlands); P. Henry, Ctr. National d'Études Spatiales (France); R. Duca, ESA ESRIN (Italy)
- 7452 OE **Status of the optical payload and processor development of ESA's Sentinel 3 mission** [7452-13]
J. Nieke, J. Frerick, J. Stroede, C. Mavrocordatos, B. Berruti, ESA ESTEC (Netherlands)
- 7452 OF **In-orbit imaging and radiometric performance prediction for flight model Geostationary Ocean Color Imager** [7452-14]
S. Jeong, Y. Jeong, D. Ryu, Yonsei Univ. (Korea, Republic of); S. Kim, Korea Aerospace Research Institute (Korea, Republic of); S. Cho, Korea Ocean Research & Development Institute (Korea, Republic of); J. Hong, I&A Technology (Korea, Republic of); S.-W. Kim, Yonsei Univ. (Korea, Republic of); H. S. Youn, Korea Aerospace Research Institute (Korea, Republic of)

SESSION 4 EARTH OBSERVING SYSTEM SENSORS I

- 7452 OG **Improving weather and climate prediction with the AIRS on Aqua** [7452-15]
T. S. Pagano, Jet Propulsion Lab. (United States)
- 7452 OH **Spectral calibration in hyperspectral sounders** [7452-16]
E. M. Manning, H. H. Aumann, R. G. Deen, Y. Jiang, Jet Propulsion Lab. (United States); L. L. Strow, S. E. Hannon, Univ. of Maryland, Baltimore County (United States)
- 7452 OI **Sensor performance of Clouds and the Earth's Radiant Energy System (CERES) instruments aboard EOS Terra and Aqua spacecraft based on post-launch calibration studies** [7452-17]
S. Thomas, Science Systems and Applications, Inc. (United States); K. J. Priestley, NASA Langley Research Ctr. (United States); P. C. Hess, R. S. Wilson, Science Systems and Applications, Inc. (United States); M. A. Avery, NASA Langley Research Ctr. (United States); D. R. Walikainen, Z. P. Szewczyk, D. L. Cooper, M. Shankar, Science Systems and Applications, Inc. (United States)
- 7452 OJ **On-orbit solar calibrations using the Aqua Clouds and Earth's Radiant Energy System (CERES) in-flight calibration system** [7452-18]
R. S. Wilson, Science Systems and Applications, Inc. (United States); K. J. Priestley, NASA Langley Research Ctr. (United States); S. Thomas, P. Hess, Science Systems and Applications, Inc. (United States)

SESSION 5 EARTH OBSERVING SYSTEM SENSORS II

- 7452 OK **MODIS solar reflective calibration traceability** [7452-19]
X. Xiong, J. Butler, NASA Goddard Space Flight Ctr. (United States)
- 7452 OL **Trends in MODIS geolocation error analysis** [7452-20]
R. E. Wolfe, NASA Goddard Space Flight Ctr. (United States); M. Nishihama, NASA Goddard Space Flight Ctr. (United States) and Sigma Space Corp. (United States)

7452 OM **On-orbit operation and performance of MODIS blackbody** [7452-21]
X. Xiong, NASA Goddard Space Flight Ctr. (United States); T. Chang, Science Systems and Applications, Inc. (United States); W. Barnes, Univ. of Maryland, Baltimore County (United States)

7452 ON **Detector dependency of MODIS polarization sensitivity derived from on-orbit characterization** [7452-22]
G. Meister, Futuretech Corp. (United States); B. A. Franz, NASA Goddard Space Flight Ctr. (United States); E. J. Kwiatkowska, ESA ESTEC (Netherlands); R. E. Eplee, SAIC (United States); C. R. McClain, NASA Goddard Space Flight Ctr. (United States)

SESSION 6 SENSORS, TECHNOLOGIES, AND MEASUREMENT TECHNIQUES

7452 OO **Staggered arrays for high resolution earth observing systems** [7452-23]
C. Latry, J.-M. Delvit, Ctr. National d'Études Spatiales (France)

7452 OP **Transmittance measurement of a heliostat facility used in the preflight radiometric calibration of Earth-observing sensors** [7452-24]
J. Czaplá-Myers, College of Optical Sciences, The Univ. of Arizona (United States); K. Thome, NASA Goddard Space Flight Ctr. (United States); N. Anderson, J. McCorkel, N. Leisso, College of Optical Sciences, The Univ. of Arizona (United States); W. Good, S. Collins, Ball Aerospace & Technologies Corp. (United States)

7452 OQ **Remote sensing capabilities of the Airborne Compact Atmospheric Mapper** [7452-27]
M. G. Kowalewski, Science Systems and Applications, Inc. (United States); S. J. Janz, NASA Goddard Space Flight Ctr. (United States)

7452 OR **A sampling technique in the star-based monitoring of GOES imager visible-channel responsivities** [7452-28]
I.-L. Chang, C. Dean, Perot Systems Corp. (United States); M. Weinreb, Riverside Technology, Inc. (United States); X. Wu, National Oceanic and Atmospheric Administration (United States)

SESSION 7 LAND REMOTE SENSING

7452 OS **Landsat-7 and Landsat-5 thermal band calibration updates** [7452-29]
J. A. Barsi, B. L. Markham, NASA Goddard Space Flight Ctr. (United States); J. R. Schott, Rochester Institute of Technology (United States); S. J. Hook, Jet Propulsion Lab. (United States); N. G. Raqueno, Rochester Institute of Technology (United States)

7452 OT **Performance results for the Landsat OLI spectral filters** [7452-30]
J. W. Figoski, N. Zaun, Ball Aerospace & Technologies Corp. (United States); T. Mooney, Barr Associates, Inc. (United States)

7452 OU **The increased potential for the Landsat Data Continuity Mission to contribute to case 2 water quality studies** [7452-31]
A. Gerace, J. Schott, Rochester Institute of Technology (United States)

SESSION 8 CROSS-CALIBRATION

- 7452 0X **The cross calibration of SeaWiFS and MODIS using on-orbit observations of the Moon** [7452-35]
R. E. Eplee, Jr., Science Applications International Corp. (United States); X. Xiong, NASA Goddard Space Flight Ctr. (United States); J.-Q. Sun, Science Systems and Applications, Inc. (United States); G. Meister, Futuretech Corp. (United States); C. R. McClain, NASA Goddard Space Flight Ctr. (United States)
- 7452 0Y **Characterization of MODIS and SeaWiFS solar diffuser on-orbit degradation** [7452-36]
X. Xiong, NASA Goddard Space Flight Ctr. (United States); R. E. Eplee, Jr., Science Applications International Corp. (United States); J. Sun, Science Systems and Applications, Inc. (United States); F. S. Patt, Science Applications International Corp. (United States); A. Angal, Science Systems and Applications, Inc. (United States); C. R. McClain, NASA Goddard Space Flight Ctr. (United States)
- 7452 10 **Radiometric characterization of hyperspectral imagers using multispectral sensors** [7452-38]
J. McCorkel, College of Optical Sciences, The Univ. of Arizona (United States); K. Thome, NASA Goddard Space Flight Ctr. (United States); N. Leisso, N. Anderson, J. Czaplá-Myers, College of Optical Sciences, The Univ. of Arizona (United States)

SESSION 9 EARTH OBSERVATION SYSTEMS AND APPLICATIONS IN CHINA

- 7452 11 **Earth observations and their applications in China (Invited Paper)** [7452-46]
X. Gu, Institute of Remote Sensing Applications (China); B. Song, Defense Industry Program Evaluation Ctr. of SASTIND (China); J. Wang, X. Zhou, Institute of Remote Sensing Applications (China)
- 7452 13 **The microwave sensor status and future developing plan of China meteorological satellites** [7452-48]
H. Yang, N. Lu, Z. Ge, H. Yin, China Meteorological Administration (China)

POSTER SESSION

- 7452 16 **An enhanced vegetation cover method for automatic generation of land surface emissivity maps** [7452-39]
E. Caselles, Univ. Politècnica de València (Spain) and Univ. de València (Spain); F. J. Abad, Univ. Politècnica de València (Spain); E. Valor, J. M. Galve, V. Caselles, Univ. de València (Spain)
- 7452 17 **Characterization of MODIS SD screen vignetting function using observations from spacecraft yaw maneuvers** [7452-40]
Z. Wang, Science Systems and Applications, Inc. (United States); X. Xiong, NASA Goddard Space Flight Ctr. (United States)
- 7452 18 **MODIS solar diffuser stability monitor: function and applications** [7452-41]
H. Chen, Science Systems and Applications, Inc. (United States); X. Xiong, NASA Goddard Space Flight Ctr. (United States)

- 7452 19 **Time-dependent response versus scan angle for MODIS reflective solar bands** [7452-43]
J. Sun, Science Systems and Applications, Inc. (United States); X. Xiong, NASA Goddard Space Flight Ctr. (United States); H. Chen, A. Angal, Science Systems and Applications, Inc. (United States); X. Geng, SAIC (United States); A. Wu, Science Systems and Applications, Inc. (United States)
- 7452 1A **Long-term monitoring of radiometer sensitivity for radiometric comparisons among optical laboratories** [7452-44]
G. Meister, Futuretech Corp. (United States); G. S. Fargion, San Diego State Univ. (United States); C. R. McClain, NASA Goddard Space Flight Ctr. (United States)

Author Index

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Carl F. Schueler, Orbital Sciences Corporation (United States)

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- 1 Prelaunch Calibration
Xiaoxiong Xiong, NASA Goddard Space Flight Center (United States)
- 2 NPOESS Preparatory Project
Kurtis J. Thome, NASA Goddard Space Flight Center (United States)
- 3 New Missions
Armin W. Doerry, Sandia National Laboratories (United States)
- 4 Earth Observing System Sensors I
Robert A. Barnes, NASA Goddard Space Flight Center (United States)
and Science Applications International Corporation (United States)

- 5 Earth Observing System Sensors II
Robert A. Barnes, NASA Goddard Space Flight Center (United States)
and Science Applications International Corporation (United States)
- 6 Sensors, Technologies, and Measurement Techniques
Denis A. Elliott, Jet Propulsion Laboratory (United States)
- 7 Land Remote Sensing
Jeffrey S. Czapla-Myers, College of Optical Sciences, The University of
Arizona (United States)
- 8 Cross-calibration
Philip E. Ardanuy, Raytheon Intelligence & Information Systems (United
States)
- 9 Earth Observation Systems and Applications in China
Xingfa Gu, Institute of Remote Sensing Applications (China)